

<b>Notice of References Cited</b>	Application/Control No. 10/808,395	Applicant(s)/Patent Under Reexamination YANO ET AL.	
	Examiner Eric W Thomas	Art Unit 2831	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,400,556	06-2002	Masuda et al.	361/523
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	WO 02/15208 A1	02-2002	WO	Omori et al.	H01G 9/042
	O	WO 00/46819	08-2000	WO	Tripp et al.	H01G9/15
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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